

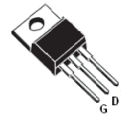
## 600VN-Channel Super Junction powerMOSFET

### DESCRIPTION

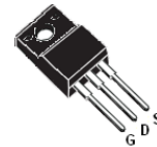
SJ MOSFET is an advanced technology for high voltage power MOSFETs, designed according to the super junction principle by Xinyuan semiconductor. The offered devices provide all benefits of a fast switching and low on resistance, making it especially suitable for applications which require more efficient, more compact, lighter, High Performance Adapter etc.

$V_{DS}$	600	V
$R_{DS(ON)}$	130	m $\Omega$
$I_D$	30	A

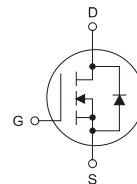
TO-220



TO-220F



TO-247



### Features

- Extremely low losses due to very low  $R_{dson} * Q_g$
- Superior Avalanche Rugged Technology
- Fast switching capability
- 100% Avalanche Tested
- Pb-free lead plating; ROHS compliant

### APPLICATIONS

- Power factor correction (PFC)
- Switched mode power supplies(SMPS)
- Uninterruptible Power Supply (UPS)
- High Performance Adapter
- LED Lighting Power

### ORDERING INFORMATION

Temperature Range	Package		Orderable Device	Package Qty.
-55°C ~ +125°C	TO-220	Pb-Free	CWS60R130BC	50 PCS/Tube
	TO-220F		CWS60R130BF	50 PCS/Tube
	TO-247		CWS60R130BZ	30 PCS/Tube



**ABSOLUTE MAXIMUM RATINGS**(T<sub>j</sub>=25°C, unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage (V <sub>GS</sub> =0V)	V <sub>DSS</sub>	600	V
Gate-Source Voltage (V <sub>DS</sub> =0V, static)	V <sub>GS</sub>	±30	V
Continuous Drain Current(T <sub>C</sub> =25 °C)(Note1)	I <sub>D(DC)</sub>	30	A
Continuous Drain Current(T <sub>C</sub> =100 °C)(Note1)	I <sub>D(DC)</sub>	19	A
Pulsed Drain Current(Note2)	I <sub>DM</sub>	89	A
MOSFET dv/dt ruggedness, V <sub>DS</sub> ≤480 V	dv/dt	50	V/nS
Single Pulsed Avalanche Energy(Note3)	E <sub>AS</sub>	720	mJ
Avalanche Energy, Repetitive(Note1)	E <sub>AR</sub>	1.2	mJ
Avalanche Current, Repetitive(Note1)	I <sub>AR</sub>	12	A
Maximum Power Dissipation (T <sub>C</sub> =25 °C)	P <sub>D</sub>	TO-220: 219 TO-220F: 34 TO-247: 219	W
Operating, Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55~150	°C

**THERMAL CHARACTERISTICS**

Parameter	Symbol	Min.	Typ.	Max.	Units
Thermal Resistance, Junction-to-Case	R <sub>thJC</sub>	-	-	TO-220: 0.57 TO-220F: 3.65 TO-247: 0.57	°C /W
Thermal Resistance, Junction-to-Ambient	R <sub>thJA</sub>	-	-	TO-220: 62 TO-220F: 80 TO-247: 62	°C /W

**ELECTRICAL CHARACTERISTICS**(T<sub>j</sub> =25°C, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	TYP.	Max.	Unit
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	600	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =600V, V <sub>GS</sub> =0V	-	-	10	μA
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±30V, V <sub>DS</sub> =0V	-	-	±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>GS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	2.0	3.0	4.0	V
Drain-Source On-state Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =15A	-	0.11	0.13	Ω
Gate Resistance	R <sub>g</sub>	F=1MHZ, open drain	-	5.2	-	Ω



## Dynamic Characteristics

( $T_j = 25^\circ\text{C}$ , unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Input capacitance	$C_{iss}$	$V_{DS}=100\text{V}, V_{GS}=0\text{V},$ $f=1\text{MHz}$	-	2227	-	pF
Output capacitance	$C_{oss}$		-	89	-	
Reverse transfer capacitance	$C_{rss}$		-	3.0	-	
Turn-on delay Time	$t_{d(on)}$	$V_{DD}=400\text{V}, I_D=15\text{A}$ $R_G=3.3\Omega, V_{GS}=10\text{V}$	-	53	-	ns
Rise time	$t_r$		-	62	-	
Turn-off delay time	$t_{d(off)}$		-	150	-	
Fall time	$t_f$		-	45	-	

## Gate charge characteristics

( $T_j = 25^\circ\text{C}$ , unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Gate to Source Charge	$Q_{gs}$	$V_{DD}=400\text{V}, I_D=15\text{A}$ $V_{GS}=0$ to 12V	-	19	-	nC
Gate to Drain Charge	$Q_{gd}$		-	15	-	
Gate Charge Total	$Q_g$		-	51	-	

## Reverse diode characteristics

( $T_j = 25^\circ\text{C}$ , unless otherwise noted)

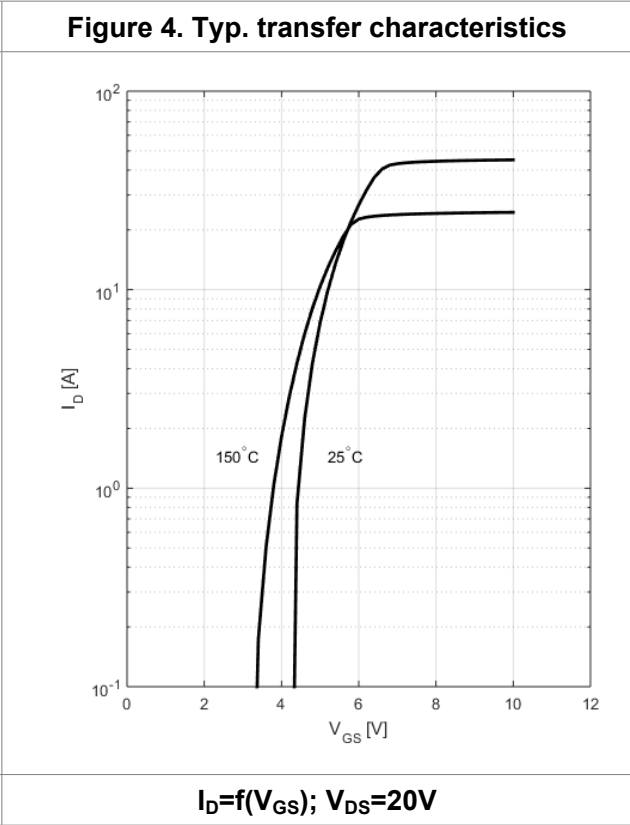
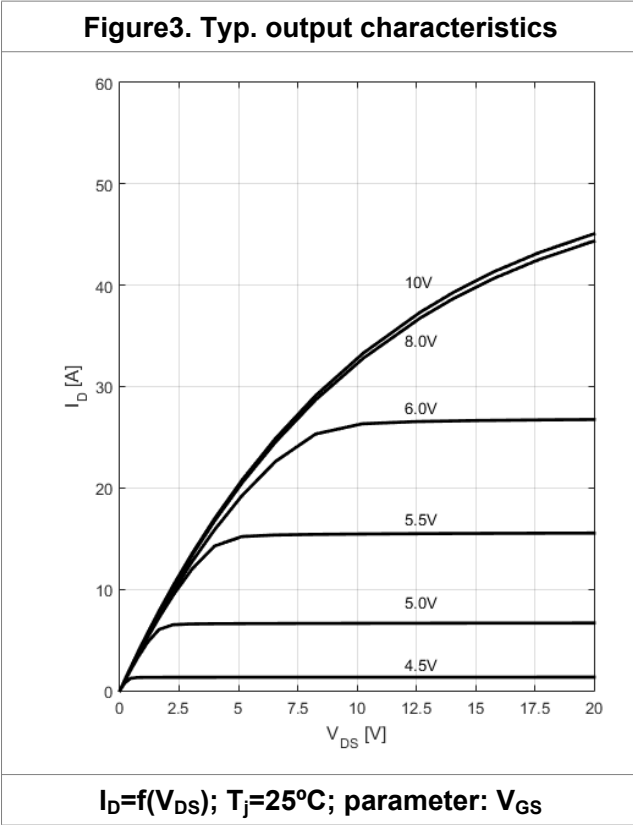
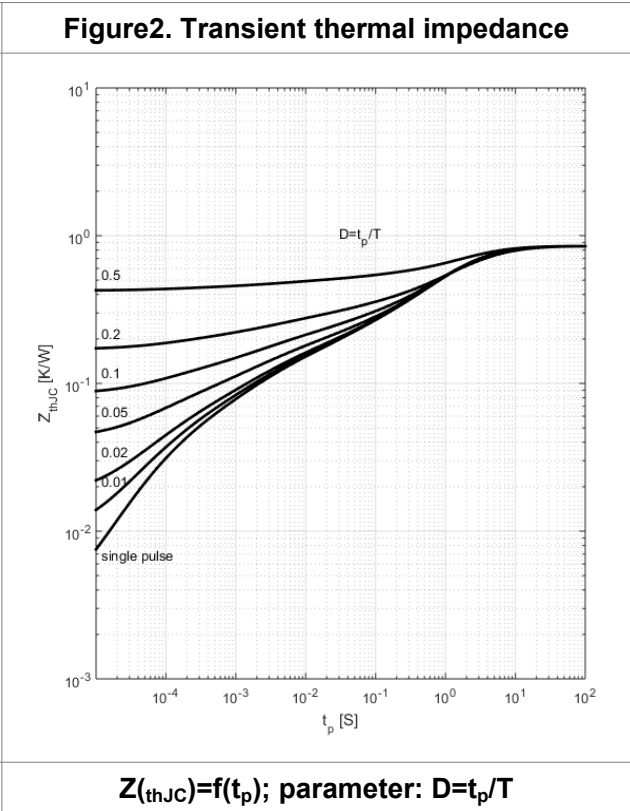
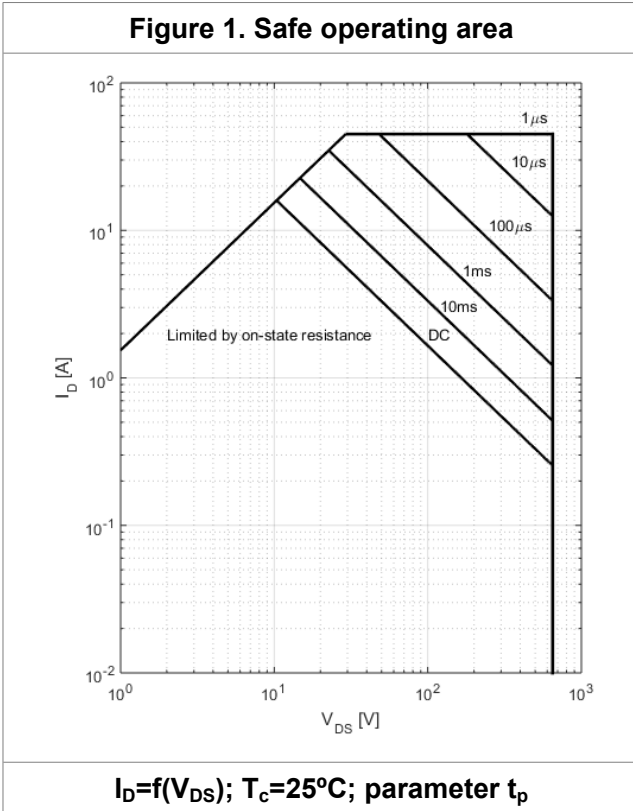
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Reverse Recovery Time	$t_{rr}$	$V_{DD}=400\text{V},$ $I_D=15\text{A}$ $V_{GS}=0$ to 10V	-	128	-	nS
Reverse Recovery Charge	$Q_{rr}$		-	1	-	$\mu\text{C}$
Peak Reverse Recovery Current	$I_{rrm}$		-	11	-	A

### Notes:

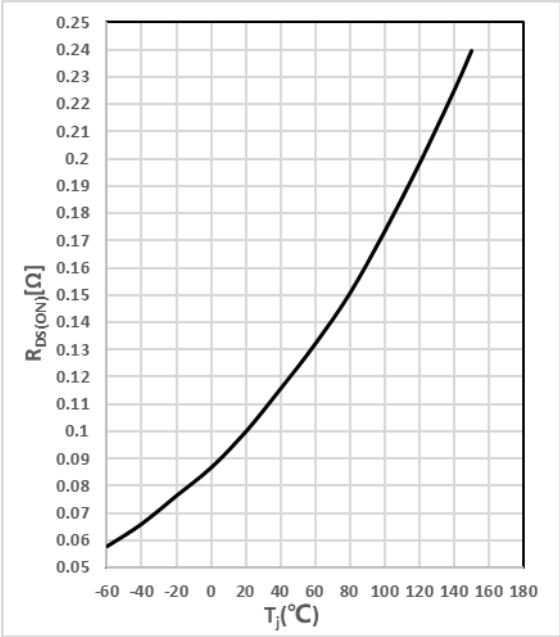
1. Limited by maximum junction temperature;
2. Pulse width limited by maximum junction temperature;
3.  $I_{AS} = 12\text{A}, V_{DD} = 50\text{V}, R_G = 25\Omega$ , Starting  $T_j = 25^\circ\text{C}$ .



**Electrical Characteristics Diagrams**

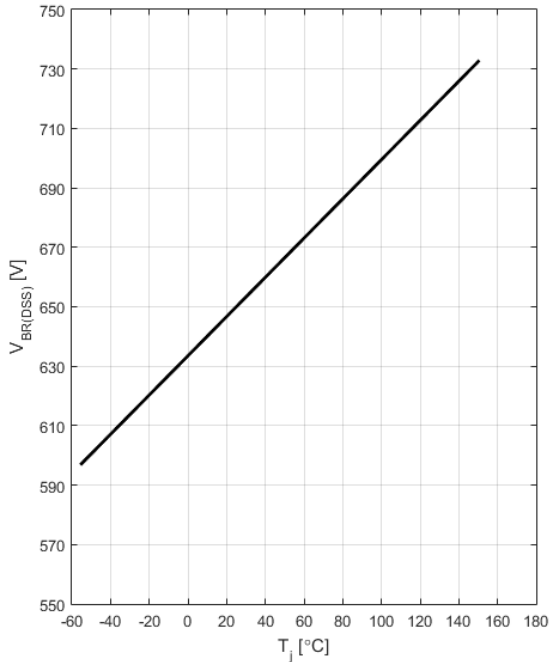


**Figure5. Drain-source on-state resistance**



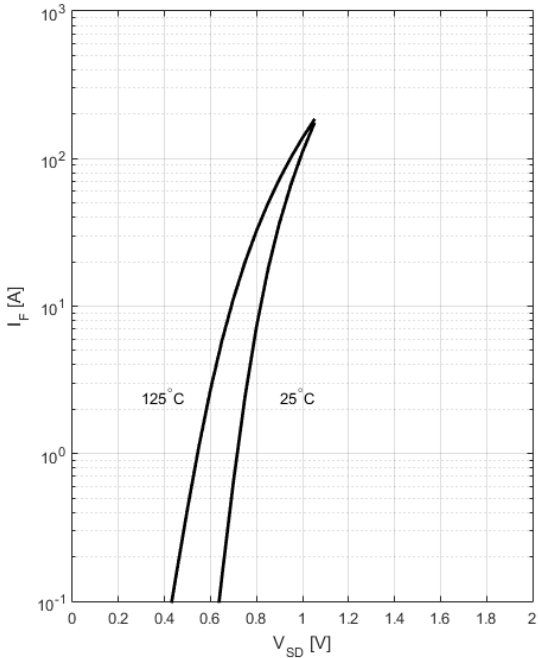
**$R_{DS(ON)}=f(T_j); I_D=30A; V_{GS}=10V$**

**Figure6. Drain-source breakdown voltage**



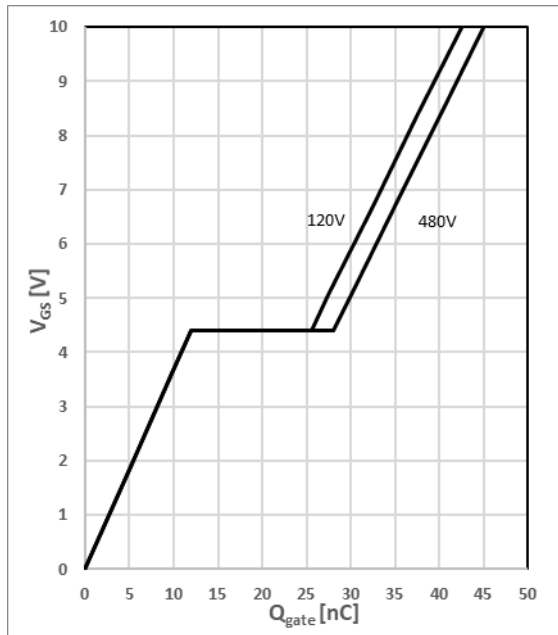
**$V_{BR(DSS)}=f(T_j); I_D=10mA$**

**Figure7. Forward characteristics of reverse diode**



**$I_F=f(V_{SD}); \text{parameter: } T_j$**

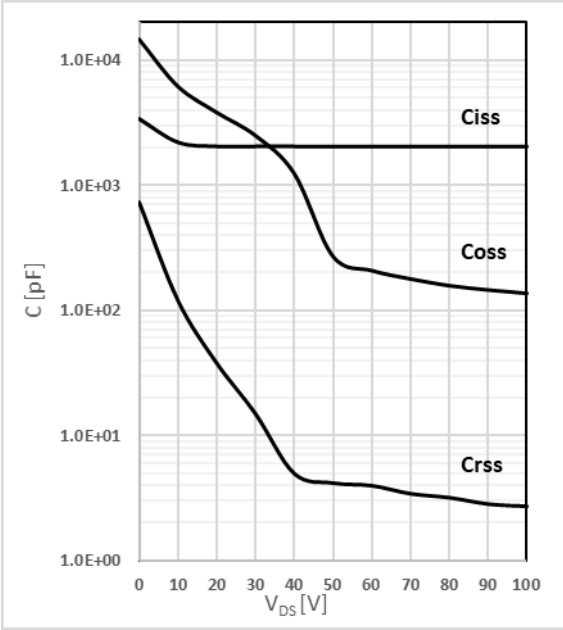
**Figure 8. Typ. gate charge**



**$V_{GS}=f(Q_{gate}), I_D=30A \text{ pulsed}$**

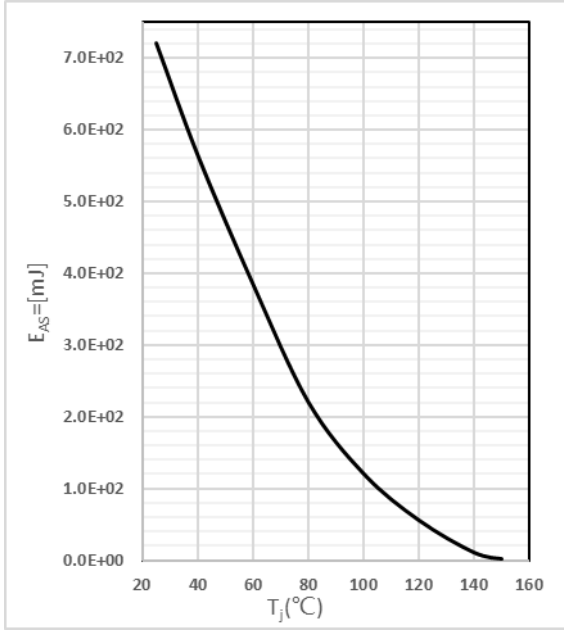


**Figure9: Typ. capacitances**



**C=f(V<sub>DS</sub>); V<sub>GS</sub>=0; f=1MHz**

**Figure10: Avalanche energy**

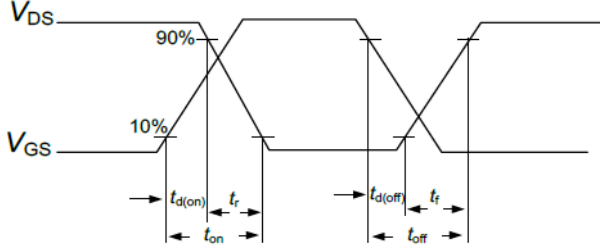
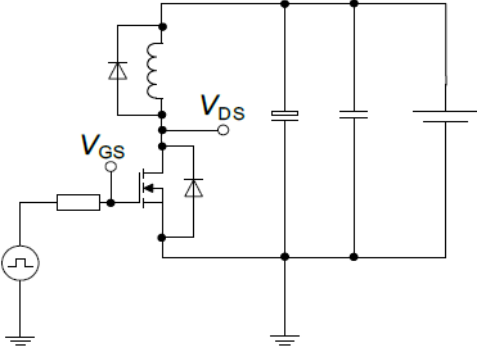


**E<sub>AS</sub>=f(T<sub>j</sub>); I<sub>D</sub>=13A; V<sub>DD</sub>=50V**

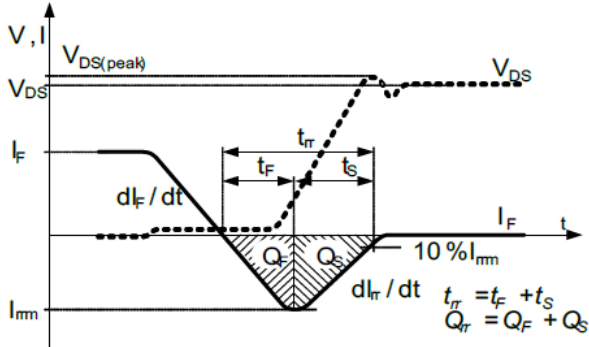
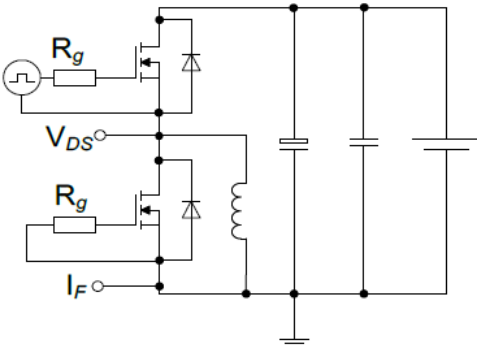


**Test Circuits**

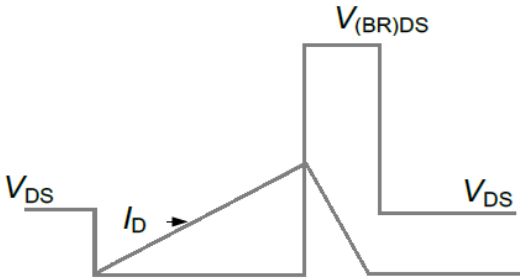
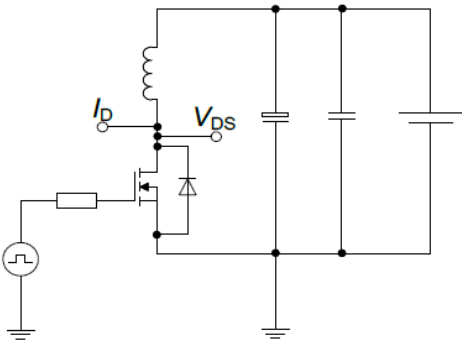
**Switch time test circuit**



**Reverse diode characteristics test circuit and waveform**

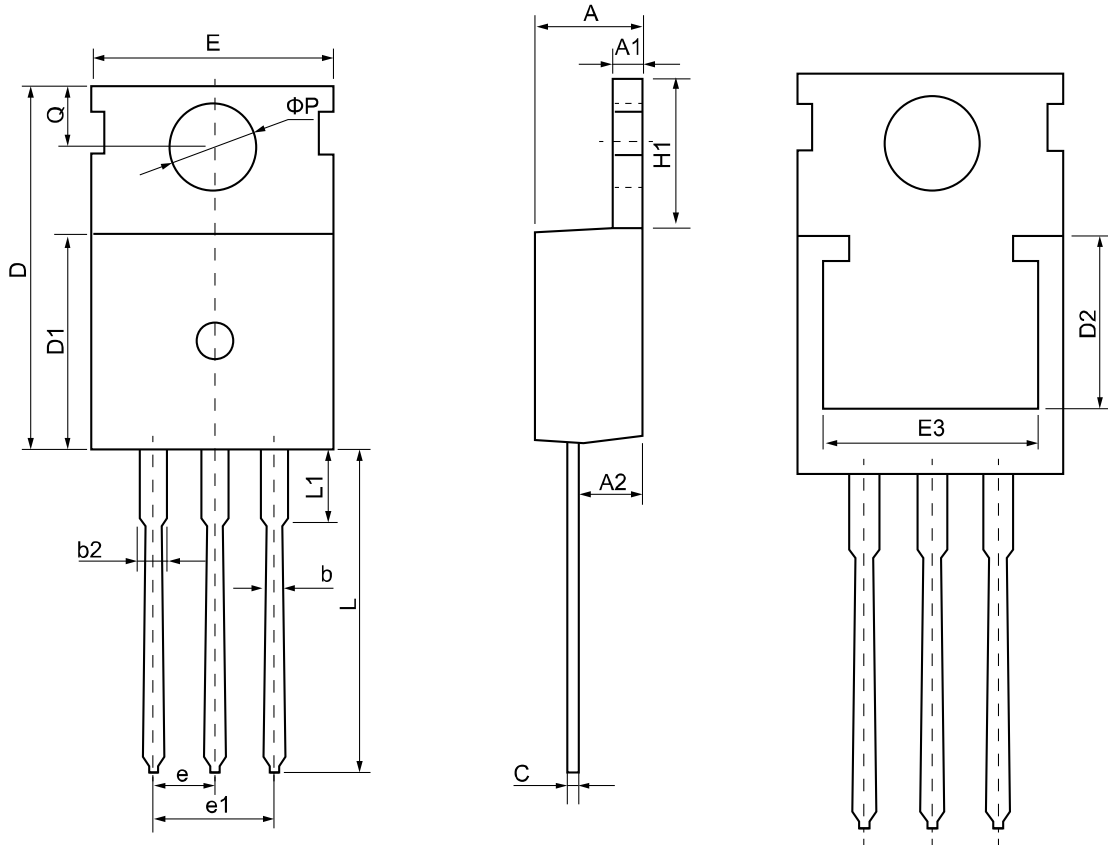


**Unclaimed inductive switching test circuit & waveform**



## PHYSICAL DIMENSIONS

TO-220

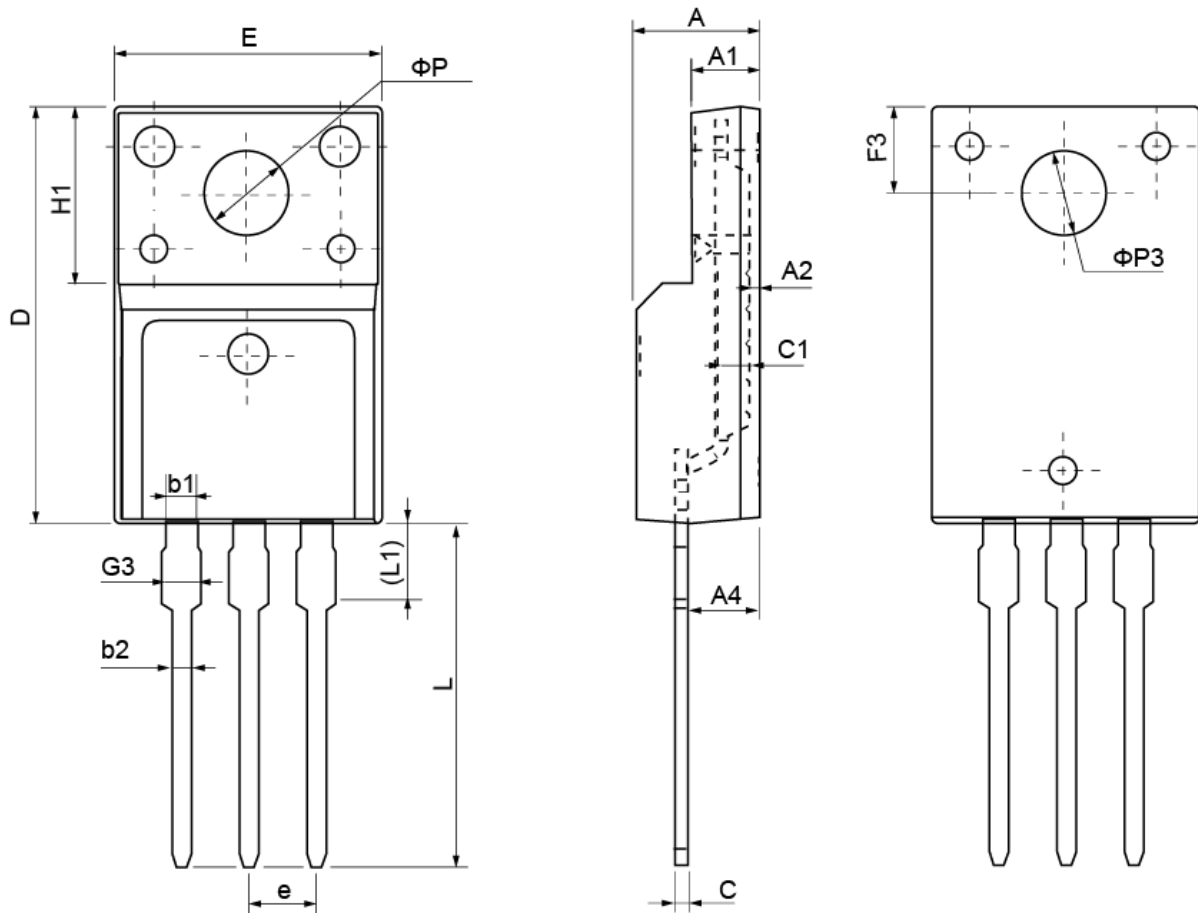


Symbol	Dimension (mm)			Symbol	Dimension (mm)		
	Min	Nom	Max		Min	Nom	Max
A	4.37	4.57	4.77	E	9.80	10.00	10.20
A1	1.25	1.30	1.45	E3	7.00	-	-
A2	2.20	2.40	2.60	e	2.54(BSC)		
b	0.70	0.80	0.95	e1	5.08(BSC)		
b2	1.17	1.27	1.47	H1	6.30	6.50	6.80
c	0.40	0.50	0.65	L	12.75	13.50	13.80
D	15.30	15.60	15.90	L1	-	3.10	3.40
D1	8.90	9.10	9.30	ΦP	3.40	3.60	3.80
D2	5.50	-	-	Q	2.60	2.80	3.00



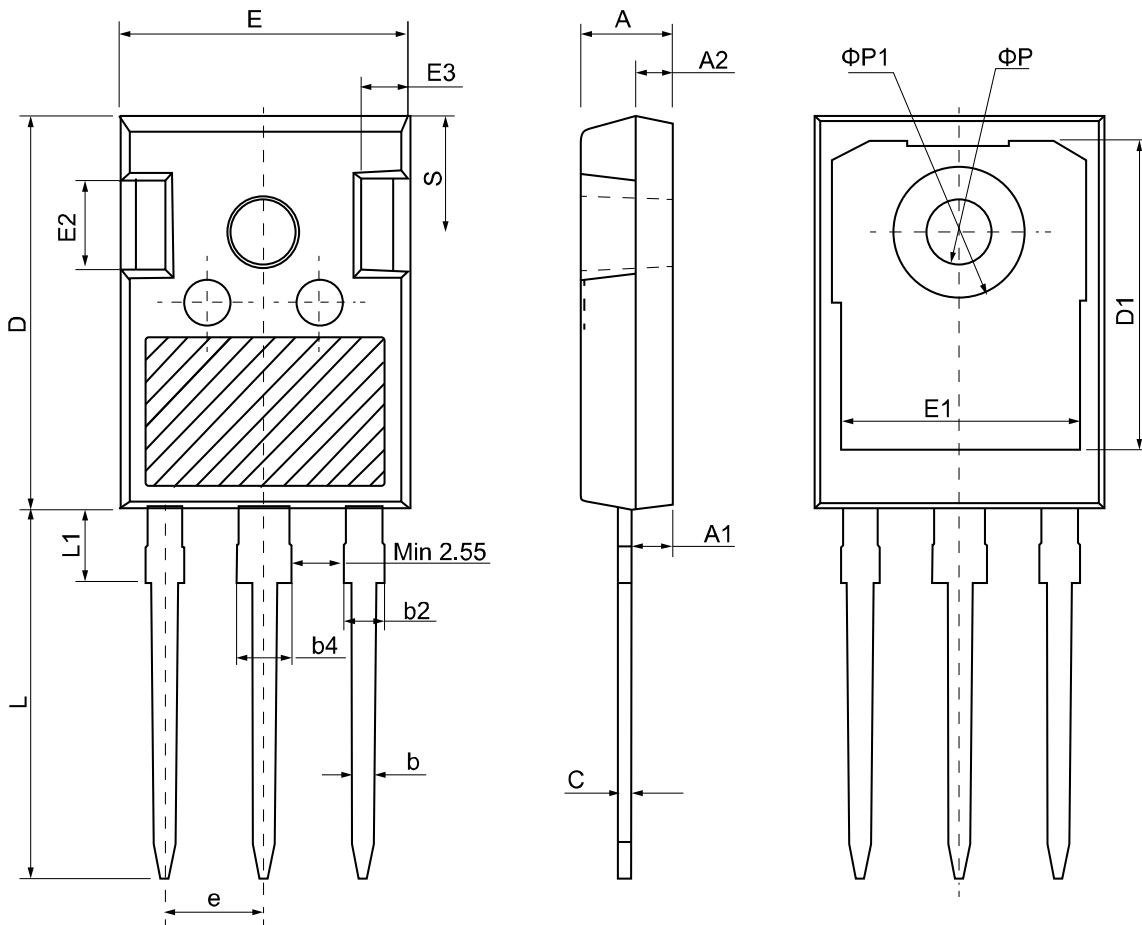


TO-220F



Symbol	Dimension (mm)			Symbol	Dimension (mm)		
	Min	Nom	Max		Min	Nom	Max
E	9.96	10.16	10.36	e	2.54(BSC)		
A	4.50	4.70	4.90	L	12.68	12.98	13.28
A1	2.34	2.54	2.74	L1	2.93	3.03	3.13
A2	0.30	0.45	0.60	$\Phi P$	3.03	3.18	3.38
A4	2.56	2.76	2.96	$\Phi P3$	3.15	3.45	3.65
c	0.40	0.50	0.65	F3	3.15	3.30	3.45
c1	1.20	1.30	1.35	G3	1.25	1.35	1.55
D	15.57	15.87	16.17	b1	1.18	1.28	1.43
H1	6.70(REF)			b2	0.70	0.80	0.95





Symbol	Dimension (mm)			Symbol	Dimension (mm)		
	Min	Nom	Max		Min	Nom	Max
A	4.80	5.00	5.20	E1	13.00	13.30	13.60
A1	2.21	2.41	2.59	E2	4.80	5.00	5.20
A2	1.85	2.00	2.15	E3	2.30	2.50	2.70
b	1.11	1.21	1.36	e	5.44(BSC)		
b2	1.91	2.01	2.21	L	19.82	19.92	20.22
b4	2.91	3.01	3.21	L1	-	-	4.30
c	0.51	0.61	0.75	$\Phi P$	3.40	3.60	3.80
D	20.80	21.00	21.30	$\Phi P1$	-	-	7.30
D1	16.25	16.55	16.85	S	6.15(BSC)		
E	15.50	15.80	16.10	-	-	-	-

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